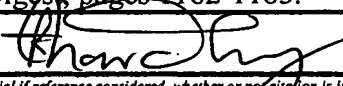


<b>FORM PTO-1449</b> <b>US DEPARTMENT OF COMMERCE</b> <b>PATENT AND TRADEMARK OFFICE</b>		Atty. Docket No. <b>83075ANAB</b> Customer No. 01333		Serial No. <b>To be Assigned</b>	
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee		Applicant: <b>Andrew F. Kurtz, et al</b>			
<b>LIST OF ART CITED BY APPLICANT</b> <i>(Use several sheets if necessary)</i>		Filing Date <b>Herewith</b>		Group <b>To be Assigned</b>	

U.S. PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T-K-C	4,441,791	4/10/84	Hornbeck	359	295	
	5,535,047	7/9/96	Hornbeck	359	295	
	5,600,383	2/4/97	Hornbeck	348	771	
	5,719,695	2/17/98	Heimbuch	359	291	
	5,914,818	6/22/99	Tejada et al.	359	663	
	5,930,050	7/27/99	Dewald	359	670	
	6,008,951	12/28/99	Anderson	359	620	
	6,089,717	7/18/00	Iwai	353	31	
	5,808,795	9/15/98	Shimomura et al.	359	488	
	5,798,819	8/25/98	Hattori et al.	353	33	
	5,918,961	7/6/99	Ueda	353	20	
	6,010,121	1/4/00	Lee	264	94	
	6,062,694	5/16/00	Oikawa et al.	353	31	
	5,652,667	7/29/97	Kurogane	349	42	
	5,767,827	6/16/98	Kobaysashi et al.	345	87	
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	2,403,731	7/9/46	MacNeille	359	488	
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	5,912,762	6/15/99	Li et al.	359	352	
	5,844,722	12/1/98	Stephens et al.	359	637	
	5,383,053	1/17/95	Hegg et al.	359	486	
	5,748,368	5/5/98	Tamada et al.	359	486	
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	6,234,634 B1	5/22/01	Hansen et al.	353	20	
	4,701,028	10/20/87	Clerc et al.	349	92	
	5,039,185	8/13/91	Uchida et al.	349	119	
	5,298,199	3/29/94	Hirose et al.	264	26	
	6,081,312	6/27/00	Aminaka et al.	349	118	
	6,141,075	10/31/00	Ohmuro et al.	349	130	
	5,576,854	11/19/96	Schmidt et al.	349	5	
	5,619,352	4/8/97	Koch et al.	349	89	
	6,585,378	7/1/03	Kurtz et al.	353	20	
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	6,496,287	12/17/02	Seiberle et al.	349	113	
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<b>FOREIGN PATENT DOCUMENTS</b>						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES   NO
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>						
T.R.C.	J. Chen, K. H. Kim, J. J. Jyu, and J. H. Souk; Optimum Film Compensation Modes for TN and VA LCDs; SID 98 Digest, pages 315-318.					
	P. Yeh; Generalized Model for Wire Grid Polarizers; SPIE Vol. 307, 1981, pages 13-21.					
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	J. J. Kuta, H. M. van Driel, D. Landheer, and Y. Feng; Coupled-Wave Analysis of Lamellar Metal Transmission Gratings for the Visible and the Infrared; Optical Society of America, Vol. 12, No. 5 (May 1995), pages 1118-1127.					
	P. Lazarev and M. Paukshto; Low-Leakage Off-Angle in E-Polarizers; SID 2001 Digest, pages 101-105.					
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	S. Roosendaal, B. van der Zande, A. Nieuwkerk, C. Renders, J. Osenga, C. Doornkamp, E. Peeters, J. Bruinink, and J. van Haaren; Novel High Performance Transflective LCD with a Patterned Retarder; SID 03 Digest, pages 78-81.					
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	H. Seiberle, C. Benecke, and T. Bachels; Photo-Aligned Anisotropic Optical Thin Films; SID 03 Digest, pages 1162-1165.					
EXAMINER				DATE CONSIDERED 06/02/04		
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>						